

<b>Notice of References Cited</b>	Application/Control No. 10/553,040	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner F. Daniel Lopez	Art Unit 3745	Page 1 of 1

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*	C	US-6,755,116 B1	06-2004	Tsubouchi et al.	91/369.2
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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